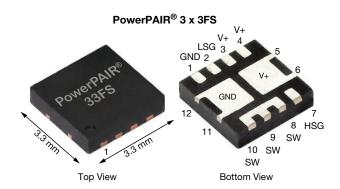
COMPLIANT

HALOGEN

FREE



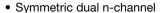
Dual N-Channel 40 V (D-S) MOSFET

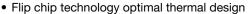


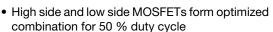
PRODUCT SUMMARY					
V _{DS} (V)	40				
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.0071				
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.0104				
Q _g typ. (nC)	6.1				
I _D (A)	61.3 ^a				
Configuration	Dual				

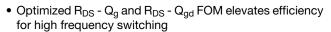
FEATURES







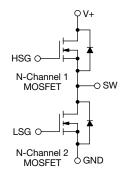




- 100 % R_g and UIS tested
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

APPLICATIONS

- Synchronous buck
- Computer / server peripherals
- Half bridge
- POL
- Telecom DC/DC



ORDERING INFORMATION	
Package	PowerPAIR 3 x 3FS
Lead (Pb)-free and halogen-free	SiZF4414DT-T1-GE3

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage		V _{DS}	40	V	
Gate-source voltage		V_{GS}	+20 / -16		
Continuous drain current (V_{GS} = 10 V, T_J = 150 °C)	T _C = 25 °C		61.3		
	T _C = 70 °C	,	49		
	T _A = 25 °C	I _D	17.2 b, c		
	T _A = 70 °C		13.7 b, c		
Pulsed drain current (V _{GS} = 10 V, t = 100 μs)	I _{DM}	120	A		
Continuous source current (MOSFET diode conduction)	T _C = 25 °C		40.1		
	T _A = 25 °C	I _S	3.2 b, c		
Single pulse avalanche current	. 0.1!!	I _{AS}	10		
Single pulse avalanche energy	L = 0.1 mH	E _{AS}	5	mJ	
Maximum power dissipation	T _C = 25 °C		48.1		
	T _C = 70 °C	-	30.8	w	
	T _A = 25 °C	P _D	3.8 b, c	VV	
	T _A = 70 °C		2.4 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150		
Soldering recommendations (peak temperature)		Ü	260		

Notes

- a. $T_C = 25 \,^{\circ}C$
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s

Vishay Siliconix

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient a, b	t ≤ 10 s	R _{thJA}	26	33	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	2	2.6	- C/W	

Notes

- a. Surface mounted on 1" x 1" FR4 board
- b. Maximum under steady state conditions is 67 °C/W

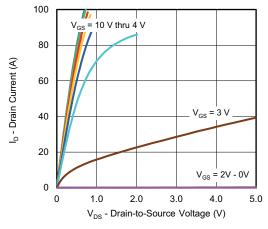
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ mA}$	40	-	-		
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D = 10 mA	-	31	-	V	
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	4.1	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	-	2.5		
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20 \text{ V} / -16 \text{ V}$	-	-	± 100	nA	
		V _{DS} = 40 V, V _{GS} = 0 V	-	-	1	† 	
Zero gate voltage drain current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V, T _J = 7.5 °C	-	-	10	μA	
	_	V _{GS} = 10 V, I _D = 10 A	_	0.0057	0.0071	Ω	
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A	_	0.0080	0.0104		
Forward transconductance ^a	9 _{fs}	V _{DS} = 10 V, I _D = 10 A	-	48	-	S	
Dynamic ^b	1 0.5	50 . 5					
Input capacitance	C _{iss}		-	1015	-	pF	
Output capacitance	C _{oss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	-	205	-		
Reverse transfer capacitance	C _{rss}		-	23	-		
Output charge	Q _{oss}	V _{DS} = 20 V, V _{GS} = 0 V	-	8.0	-	nC	
Tatalanda akan a		V _{DS} = 20 V, V _{GS} = 10 V, I _D = 10 A	-	13.3	20		
Total gate charge	Qg	50 / G0 / 5	-	6.1	9.5	nC	
Gate-source charge	Q_{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 10 \text{ A}$	-	3.4	-		
Gate-drain charge	Q_{gd}		-	0.9	-		
Gate resistance	R_g	f = 1 MHz	2.0	4.2	7.2	Ω	
Turn-on delay time	t _{d(on)}		-	8	16		
Rise time	t _r	$V_{DD} = 20 \text{ V}, R_1 = 2 \Omega, I_D \cong 10 \text{ A},$	_	5	10		
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	18	36		
Fall time	t _f		-	4	8		
Turn-on delay time	t _{d(on)}		-	16	32	ns	
Rise time	t _r	$\begin{split} V_{DD} &= 20 \text{ V, } R_L = 2 \Omega, I_D \cong 10 \text{ A,} \\ V_{GEN} &= 4.5 \text{ V, } R_g = 1 \Omega \end{split}$	-	66	130		
Turn-off delay time	t _{d(off)}		-	18	36		
Fall time	t _f		-	9	18		
Drain-source Body Diode Characteris	stics						
Continuous source-drain diode current	I _S	T _C = 25°C	-	-	40.1	٨	
Pulse diode forward current	I _{SM}		-	-	120	Α	
Body diode voltage	V_{SD}	I _S = 5 A, V _{GS} = 0 V	-	0.78	1.2	V	
Body diode reverse recovery time	t _{rr}		-	17	34	ns	
Body diode reverse recovery charge	Q _{rr}	I _F = 10 A, di/dt = 100 A/μs,	-	6	12	nC	
Reverse recovery fall time	t _a	T _J = 25 °C	-	7	-		
Reverse recovery rise time	t _b		-	10	-	ns	

Notes

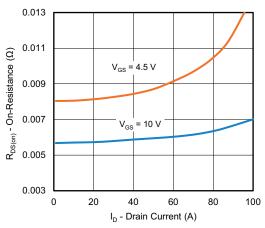
- a. Pulse test; pulse width $\leq 300 \, \mu s$, duty cycle $\leq 2 \, \%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

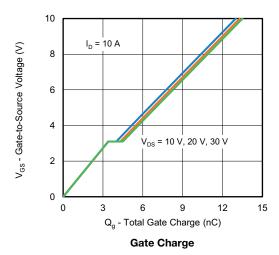


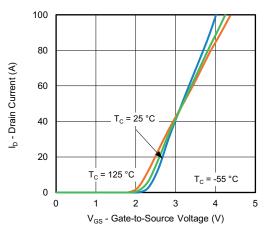


Output Characteristics

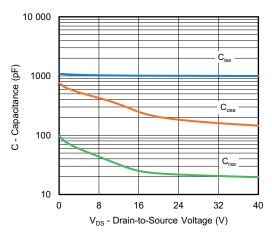


On-Resistance vs. Drain Current and Gate

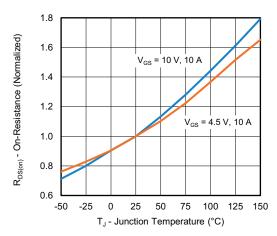




Transfer Characteristics

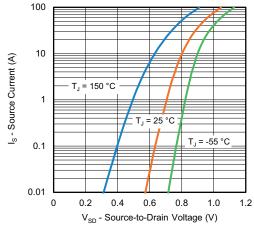


Capacitance

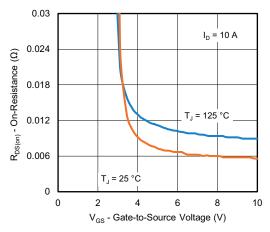


On-Resistance vs. Junction Temperature

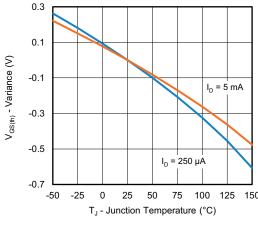




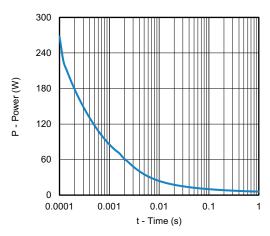
Source-Drain Diode Forward Voltage



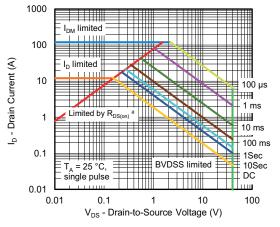
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power

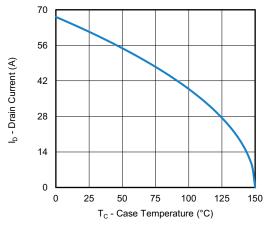


Safe Operating Area, Junction-to-Ambient

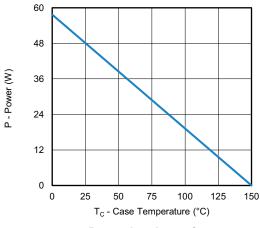
Note

a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

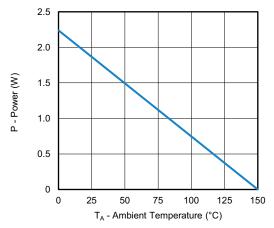




Current Derating a



Power, Junction-to-Case

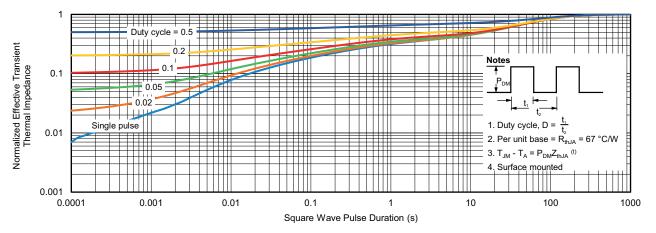


Power, Junction-to-Ambient

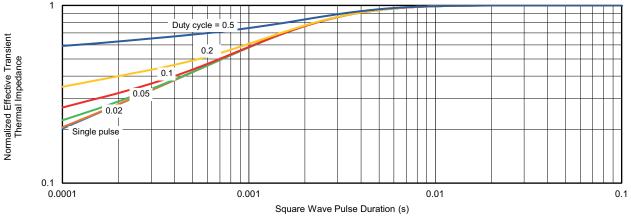
Notes

- a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-ambient thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit
- b. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified





Normalized Thermal Transient Impedance, Junction-to-Ambient

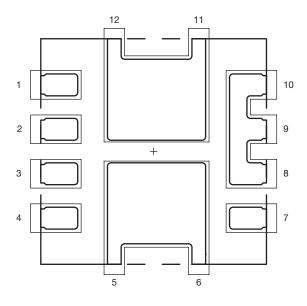


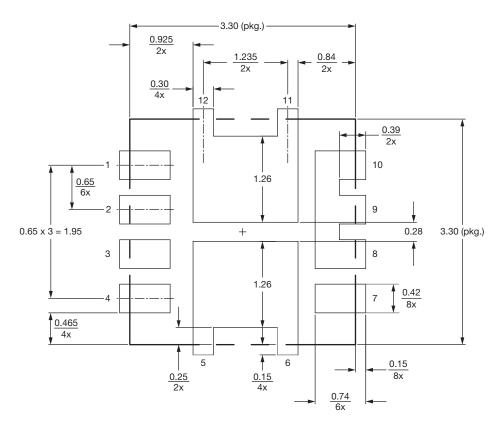
Normalized Thermal Transient Impedance, Junction-to-Case

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Recommended Land Pattern PowerPAIR® 3 x 3FS BWL





Note

• Dimensions in mm

ECN: T23-0180-Rev. B, 16-May-2023

DWG: 3006



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